



# Scanning Electron Microscope

## SEM3200

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## Product Introduction

SEM3200 is a tungsten filament scanning electron microscope with high performance and wide application.

It has excellent imaging quality capabilities in both high and low vacuum modes. It also has a large depth of field with a user friendly environment to characterize samples. What's more, rich scalability helps the users to explore the world of microscopic imaging.

### Resolution

**High vacuum:** 3 nm @ 30 kV (SE), 8 nm @ 3 kV (SE), 4 nm @ 30 kV (BSE)

<sup>①</sup>**Low vacuum:** 3 nm @ 30 kV (SE)

### Magnification

<sup>②</sup>1~300,000x, <sup>③</sup>1~1000,000x

### Acceleration Voltage

0.2 kV ~ 30 kV

① Low vacuum secondary electronic detector optional

② Magnification of film

③ Magnification of screen

## Product Advantages

(\*optional)



### Scalability

SE\BSE\EDS\EBSD, etc



### Optical navigation

quickly navigate the region of interest (ROI)



### \*Large image mapping

Automatic image acquisition and stitching



### Mixing imaging (SE+BSE)

The composition and surface information of the sample is observed in an image



### \*Tetrode emission system

Tetrode design provides excellent resolution under low landing energy



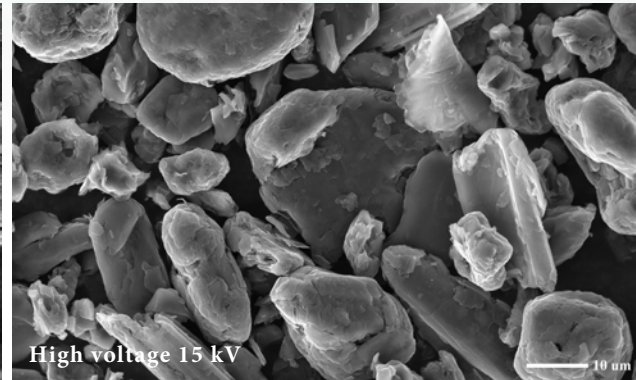
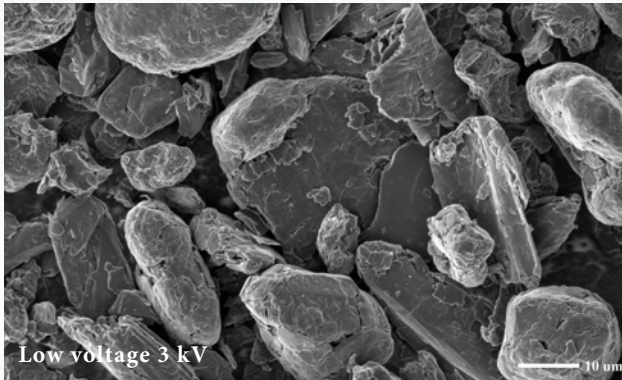
### \*Low vacuum mode

Provides sample surface details and morphology at low vacuum, and the software switches the vacuum state with one click

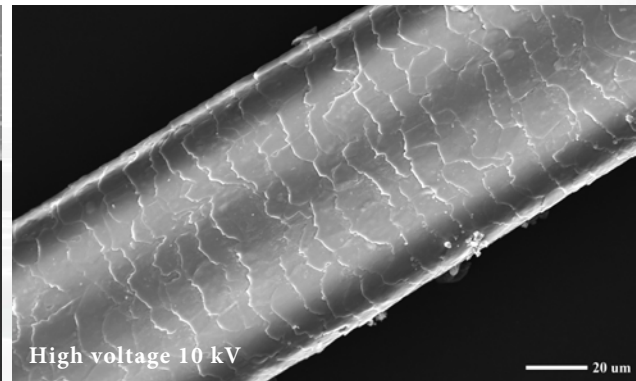
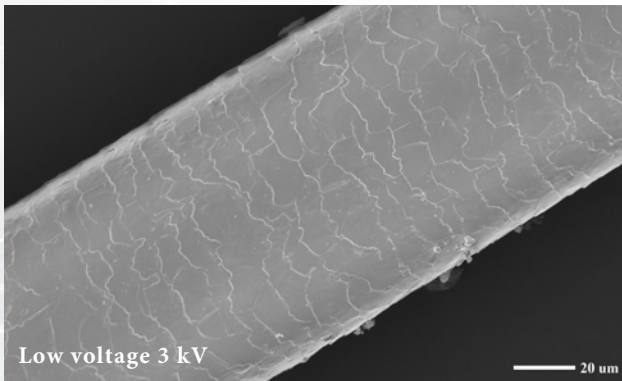
## Product Features (\*Optional)

### ► Low voltage

For carbon material samples, at low voltage, the penetration depth is small, and the true morphology of the sample surface can be obtained with richer details.

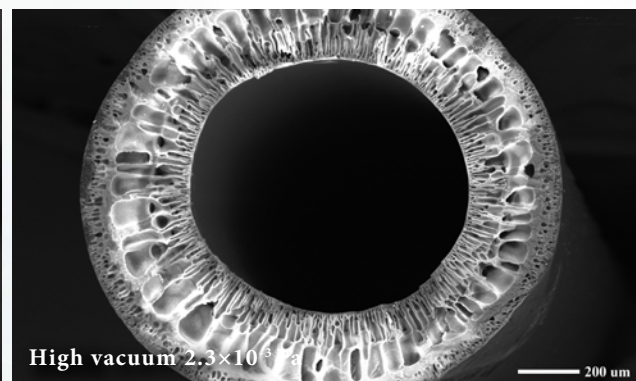
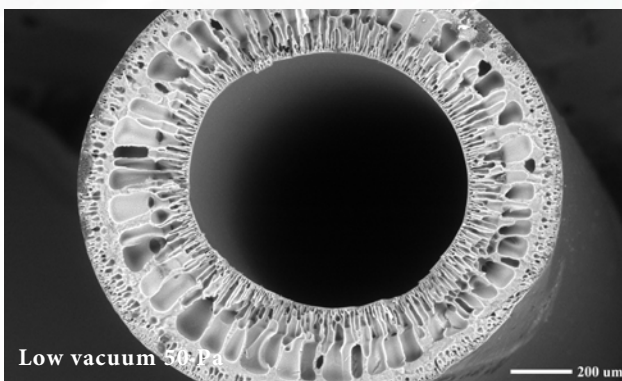


For hair samples, at low voltage, the damage of electron beam irradiation is reduced and the charge effect is eliminated.



### ► Low vacuum

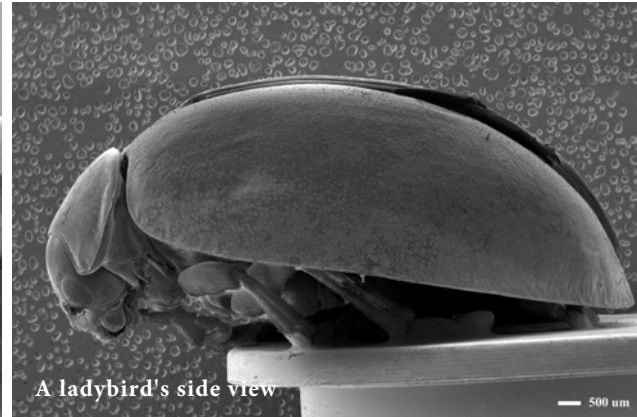
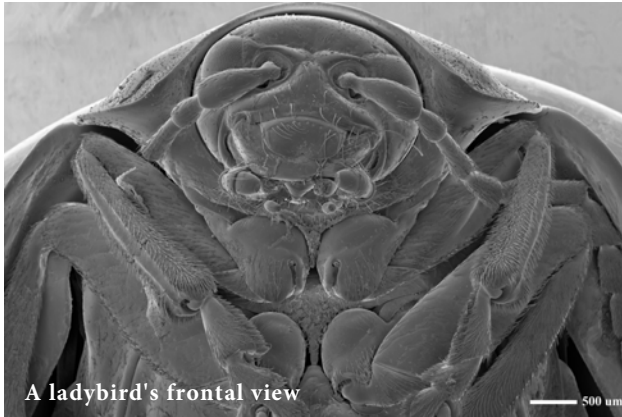
The filter fiber tube material has poor electrical conductivity and obvious charge under high vacuum. Under low vacuum, the non-conductive sample can be directly observed without coating.





## ► Wide field of view

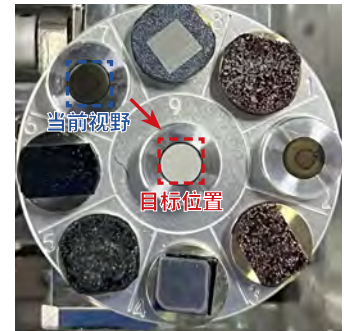
Biological samples can easily obtain the overall morphology and head structure details of the ladybug by using wide-field observation, and display cross-scale analysis.



## ► Navigation & Anti-collision

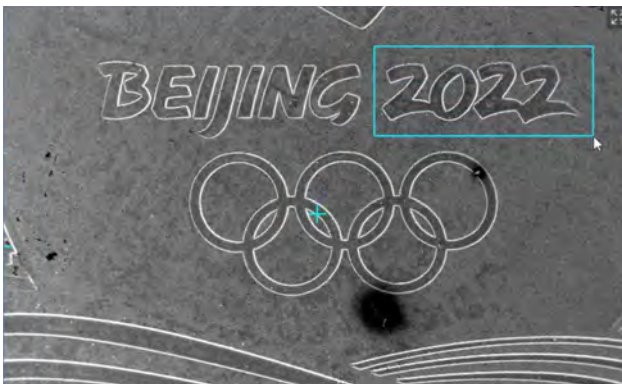
### Optical navigation

The standard camera in the warehouse can take high-definition photos of the sample station and quickly locate the sample.



### Gesture shortcut navigation

Box selection and magnification: under the low-power navigation, you can get a large field of view of the sample, which can quickly select the sample area you are interested in, improving work efficiency.



### Anti-collision technology

Multi-dimensional anti-collision scheme:

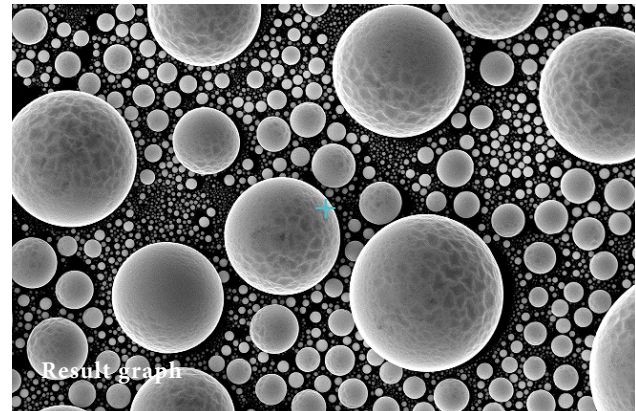
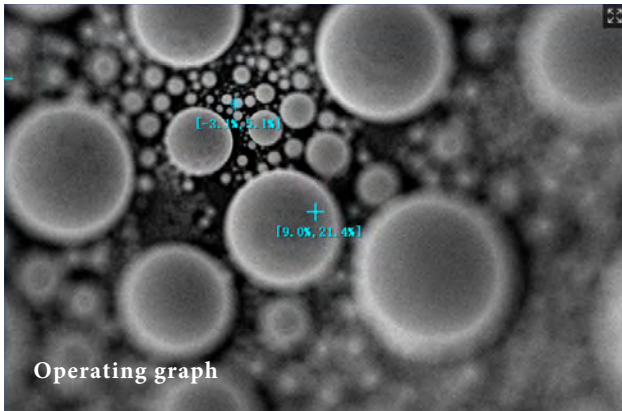
1. Manually input the sample height to accurately control the distance between the sample and the lower end of the objective to prevent collision;
2. Based on image recognition and dynamic capture technology, real-time monitoring of the pictures in the warehouse in the process of movement;
3. Hardware anti-collision, can stop the motor at the moment of collision, reduce collision damage. (\*SEM3200A requires this function)



## ► Feature function

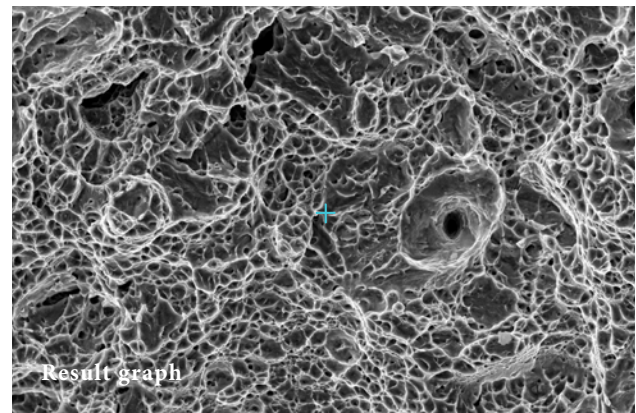
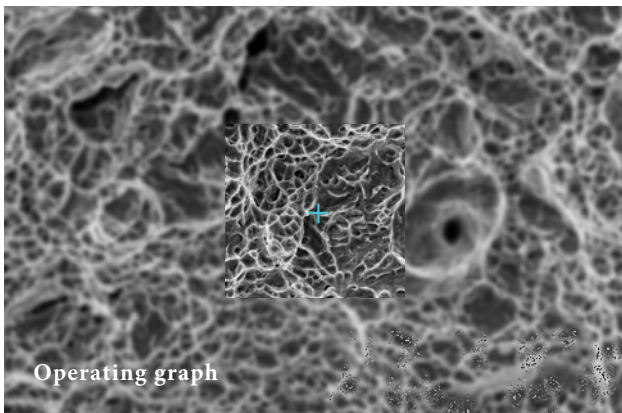
### Intelligent assisted astigmatism

Directly reflect the astigmatism of the whole field of vision, through the mouse click clear, can quickly adjust the astigmatism to the best.



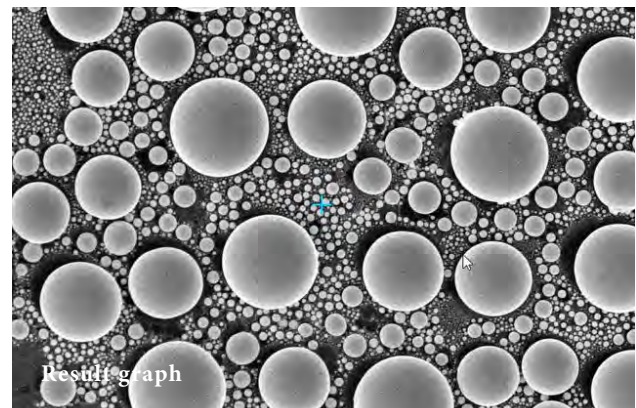
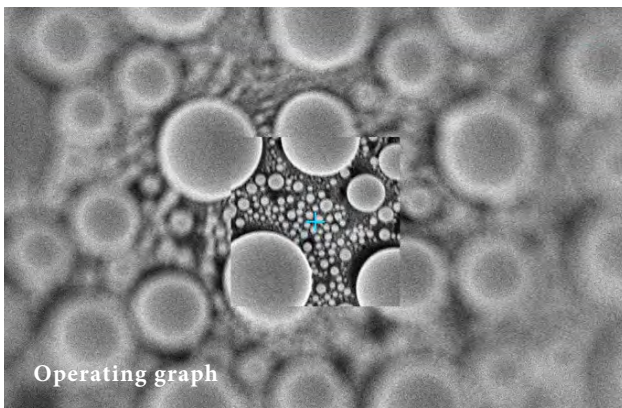
### Autofocus

One-click focus for fast imaging.



### Automatic astigmatism

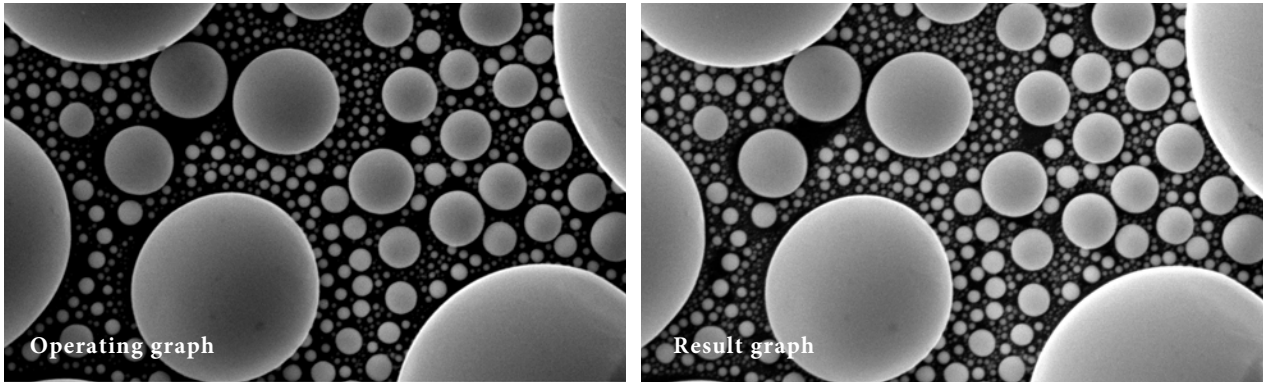
One-click astigmatism, improve efficiency.





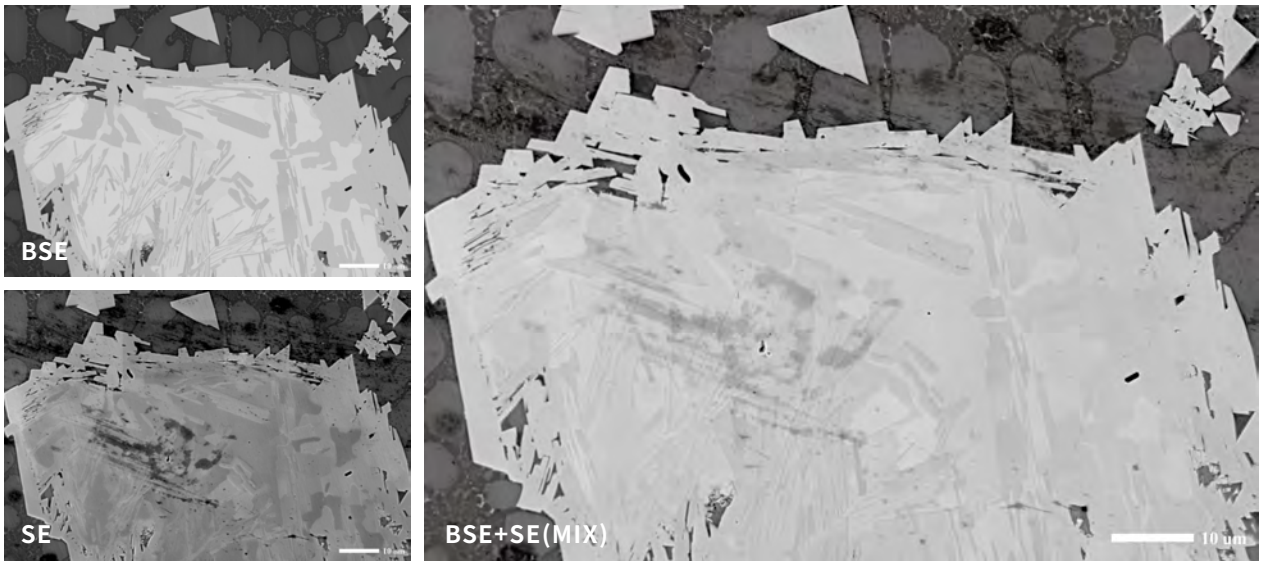
### Automatic brightness contrast

One-click automatic brightness contrast, gray level appropriate image.



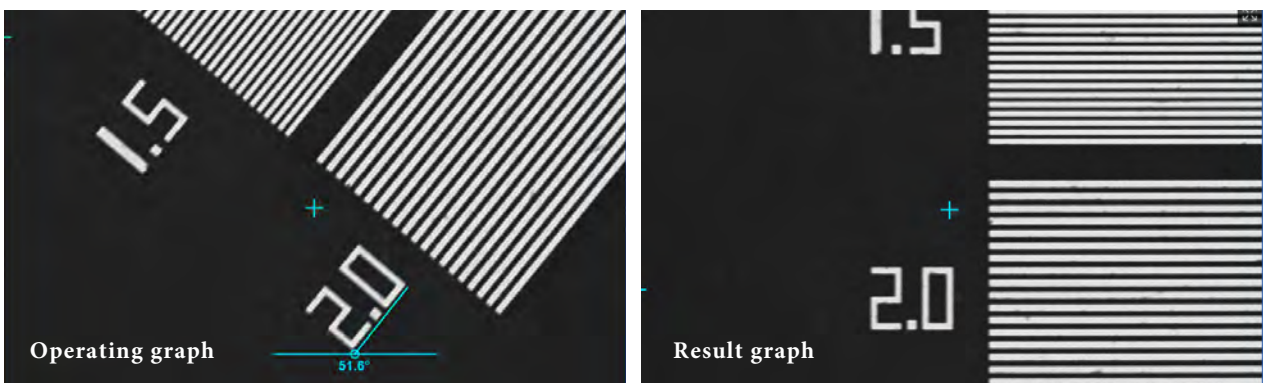
### Image multiple information simultaneously

SEM3200 supports one-click switching between SE and BSE hybrid imaging, the morphology and composition information of samples can be observed simultaneously.



### Fast image rotation

Drag a line and the image is instantly "angled".



## ► Rich scalability

Scanning electron microscope is not only limited to the observation of surface morphology, but also can be used to analyze the micro-components of the sample surface.

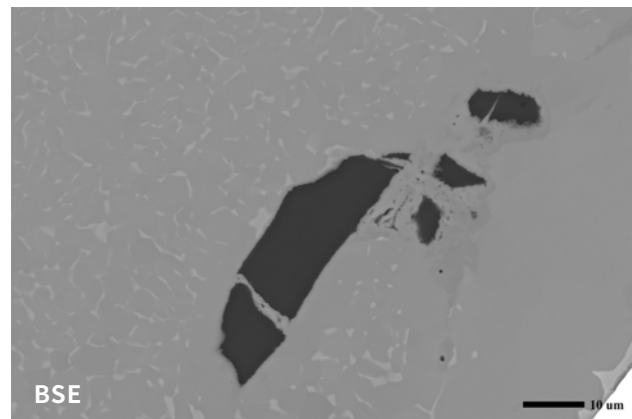
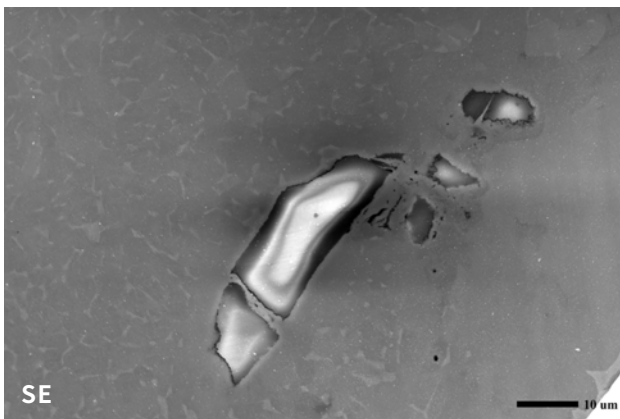
In addition to conventional secondary electron detector (ETD), backscattered electron detector (BSED), and X-ray energy dispersive spectrometer (EDS), many interfaces are reserved, such as electron backscattered diffraction (EBSD), cathode ray (CL) detectors can be integrated on SEM3200.

### Backscattered electron detector

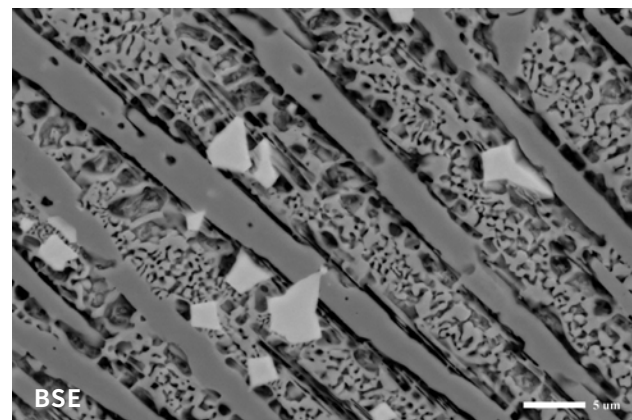
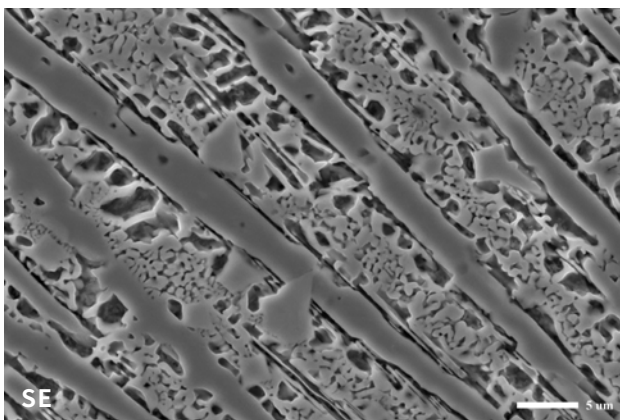
#### Contrast between secondary electron imaging and backscattered electron imaging

In the backscattered electron imaging mode, the charge effect is weakened obviously, and more composition information can be obtained on the sample surface.

Coating sample:



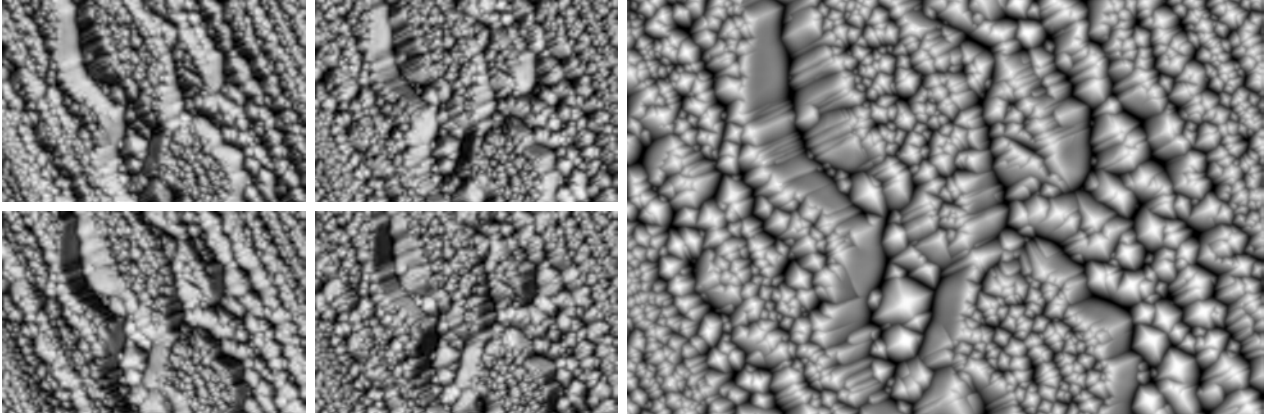
Tungsten steel alloy sample:





### Quadripartite backscattered electron detector -- multichannel imaging

The detector is exquisitely designed and highly sensitive. It adopts a 4-segment design, and can obtain shadow images and component distribution images in different directions without tilting the sample.

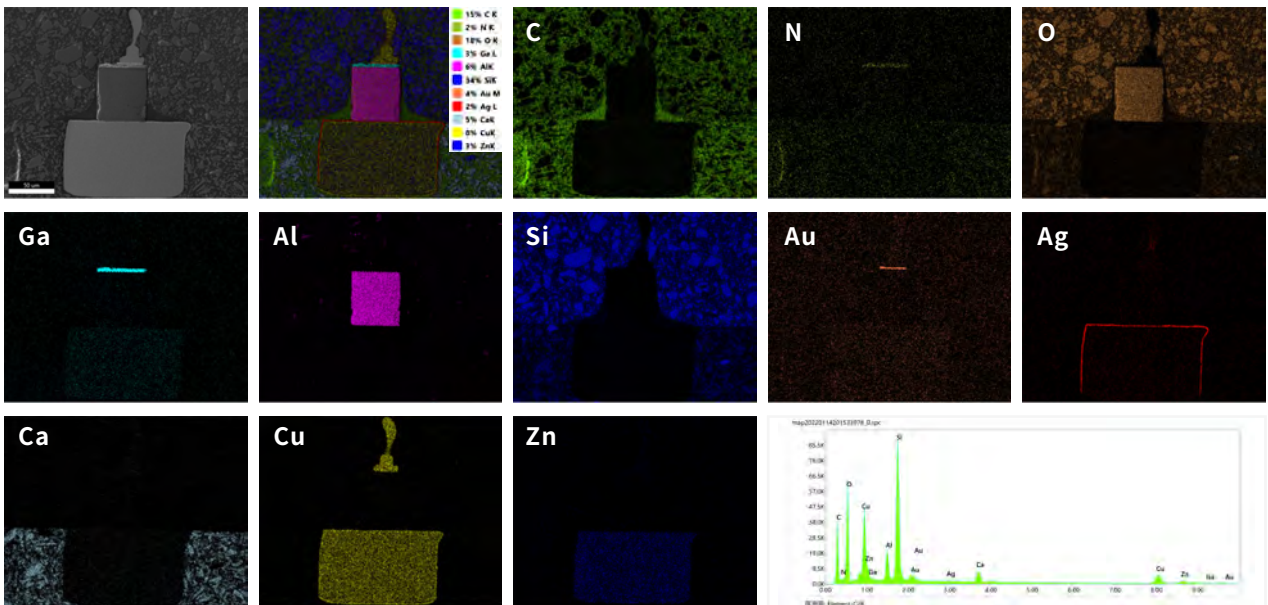


Four single-channel shadow images

Composition image

### X-ray energy dispersive spectrometer (EDS)

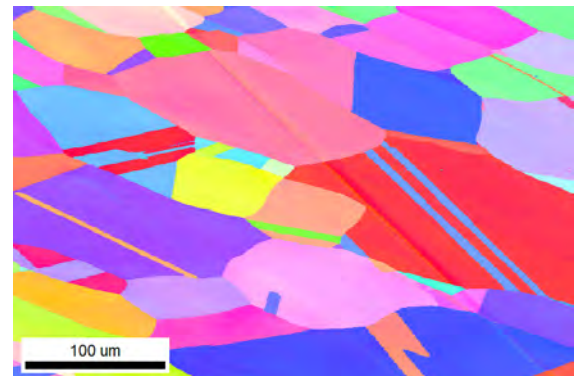
EDS analysis results of LED beads.



### Electron backscatter diffraction

Tungsten filament has a large electron microscope beam, which fully meets the testing requirements of high resolution EBSD. It can calibrate the crystal orientation and analyze the grain size of polycrystalline materials such as metals, ceramics and minerals.

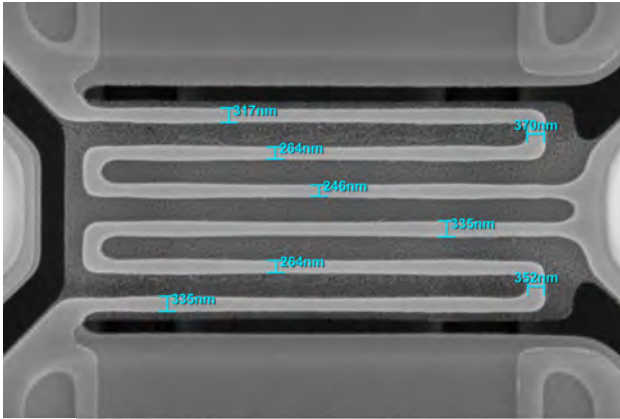
The EBSD reverse polar diagram of Ni metal standard samples can identify grain size and orientation, grain boundaries and twins, and accurately judge the material structure.





# Application

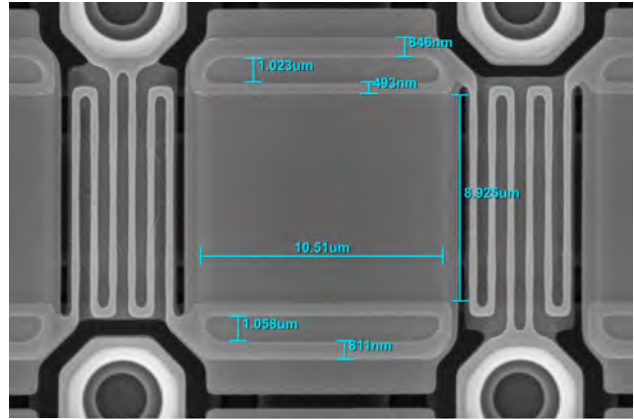
## Semiconductors and electronic components



SEM3200 ETD SE HV 10kV MAG.S x30000 HFW 13.55um WD 5.18mm High.V 1.5e-3Pa

Chip-1

Acceleration voltage: 10 KV / magnification: ×30000

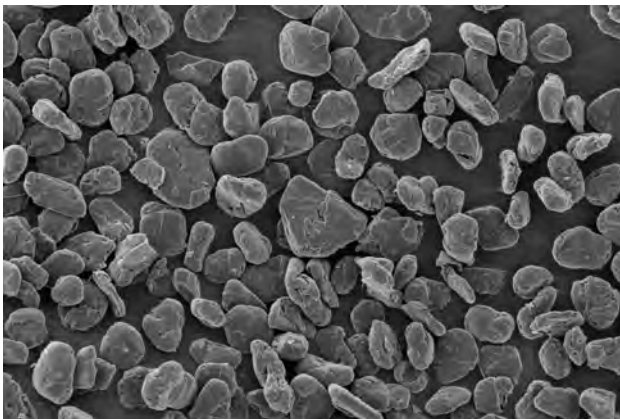


SEM3200 ETD SE HV 10kV MAG.S x15000 HFW 27.09um WD 5.18mm High.V 1.2e-3Pa

Chip-2

Acceleration voltage: 10 KV / magnification: ×15000

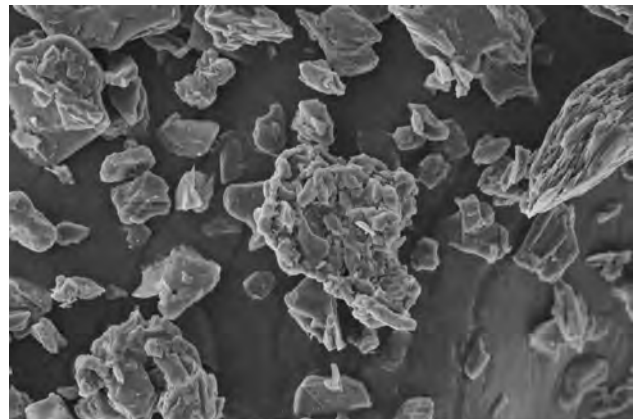
## Batteries and new energy



SEM3200 ETD SE HV 5kV MAG.P x1000 HFW 0.13mm WD 4.98mm High.V 2.1e-3Pa

Negative electrode -- carbon

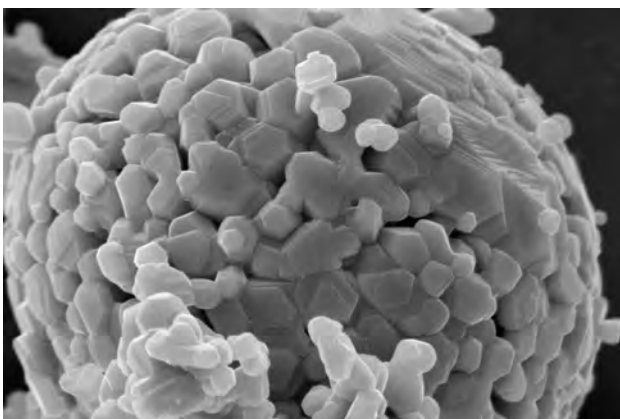
Acceleration voltage: 5 KV/ Magnification: ×1000



SEM3200 ETD SE HV 10kV MAG.P x1000 HFW 0.13mm WD 4.51mm High.V 6.9e-4Pa

Negative electrode - carbon coated silicon

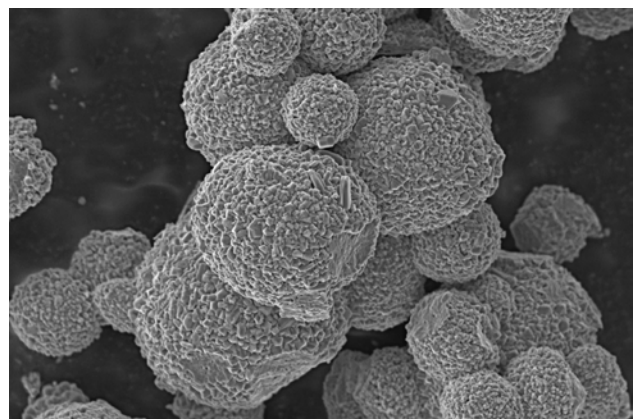
Acceleration voltage: 10 KV/magnification: ×1000



SEM3200 ETD SE HV 15kV MAG x10000 HFW 20.32um WD 10mm

Positive electrode --Lithium cobaltate

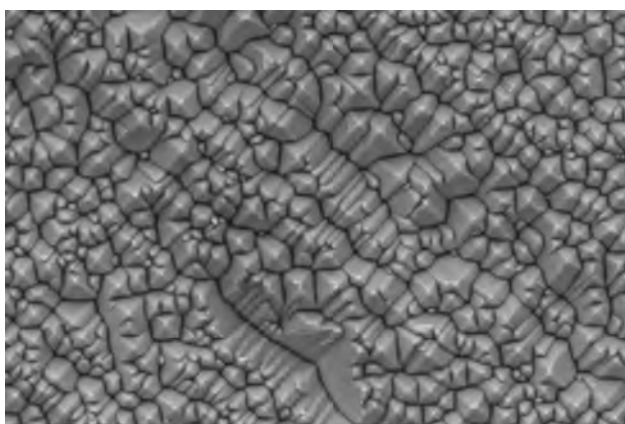
Acceleration voltage: 15 KV/ Magnification: ×10000



SEM3200 ETD SE HV 5kV MAG.P x3000 HFW 42.71um WD 6.03mm High.V 4.9e-4Pa

Positive electrode --Lithium manganate

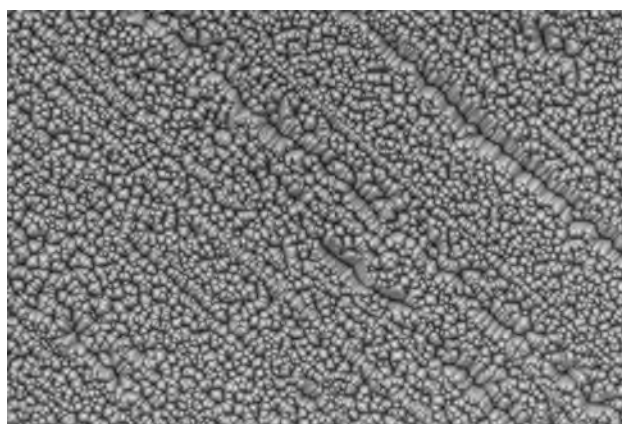
Acceleration voltage: 5 KV/ Magnification: ×3000



SEM3200 ETD SE HV 5kV MAG x15000 HFW 27.09um WD 6mm | 2um

Solar cell-1

Acceleration voltage: 5 KV/ Magnification: ×10000

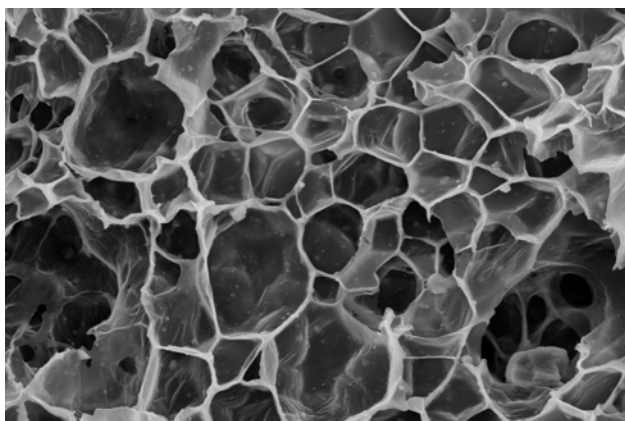


SEM3200 ETD SE HV 10kV MAG x5000 HFW 81.28um WD 6mm | 10um

Solar cell-2

Acceleration voltage: 10 KV/ Magnification: ×5000

### Polymer material

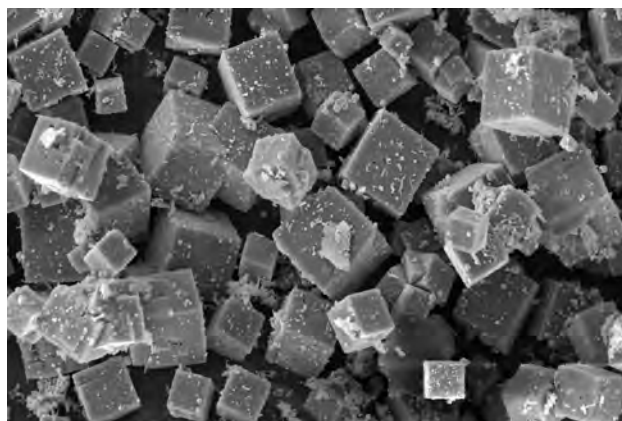


SEM3200 ETD SE HV 15kV MAG.S x5000 HFW 81.28um WD 11.61mm High.V 8.1E-4Pa | 10um

Polymer foam

Acceleration voltage: 15 KV/ Magnification: ×5000

### Chemicals

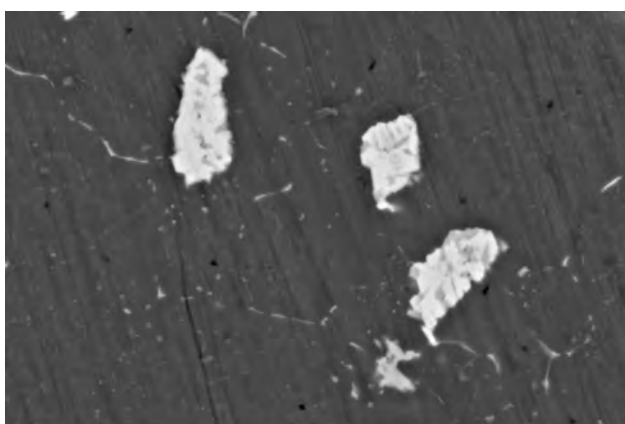


SEM3200 ETD SE HV 15kV MAG x2000 HFW 0.20mm WD 8mm | 20um

Catalyst -MOF material

Acceleration voltage: 15 KV/ Magnification: ×2000

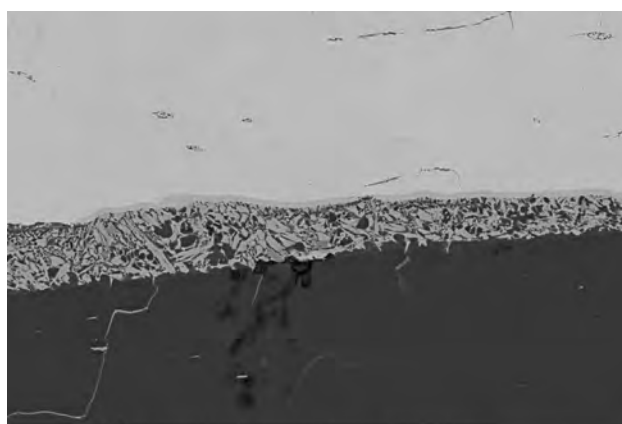
### Metal



SEM3200 BSED Comp HV 15kV MAG x10000 HFW 40.64um WD 8mm | 5um

2A12 Aluminium alloy precipitated phase

Acceleration voltage: 15 KV/ Magnification: ×10000

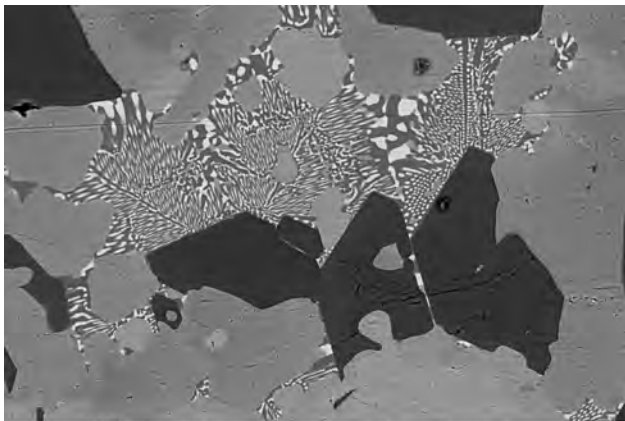


SEM3200 BSED Comp HV 15kV MAG.S x2000 HFW 0.20mm WD 6.91mm High.V 3.4E-4Pa Frames 1 | 20um

Mg-ZnAlloy compound layer

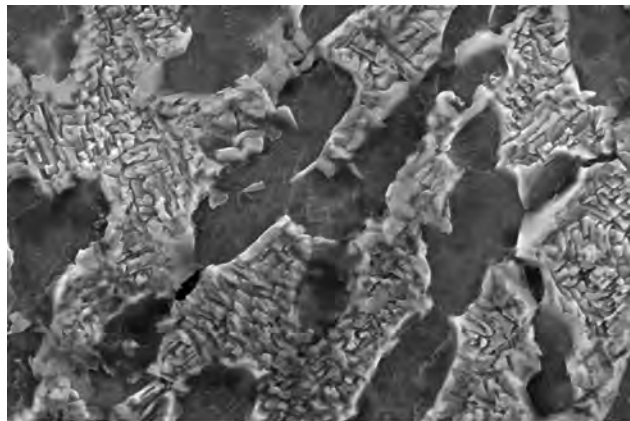
Acceleration voltage: 15 KV/ Magnification: ×2000





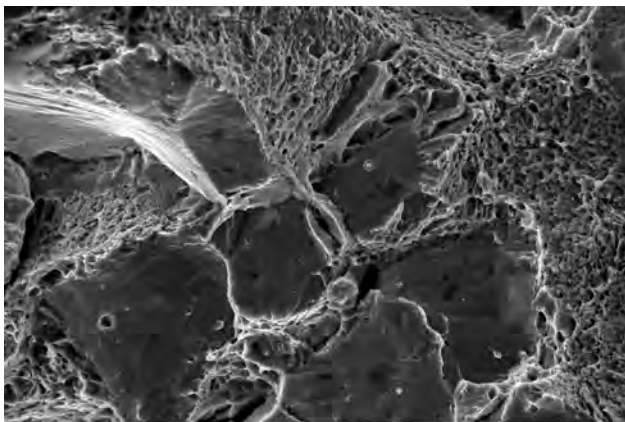
SEM3200 BSED HV MAG.S HFW WD High.V Frames  
Comp 15kV x5000 81.28um 5.35mm 8.4E-4Pa 1 10um

Stainless steel - brass welds  
Acceleration voltage: 15 KV/ Magnification: ×5000



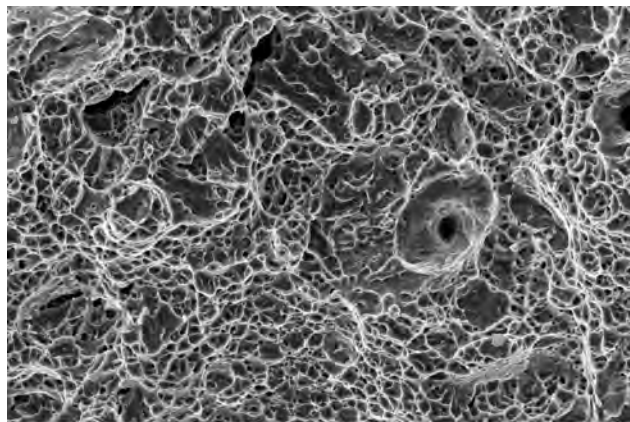
SEM3200 ETD HV MAG HFW WD  
SE 20kV x30000 13.55um 8mm 1um

Titanium alloy matrix structure  
Acceleration voltage: 20 KV/ Magnification: ×30000



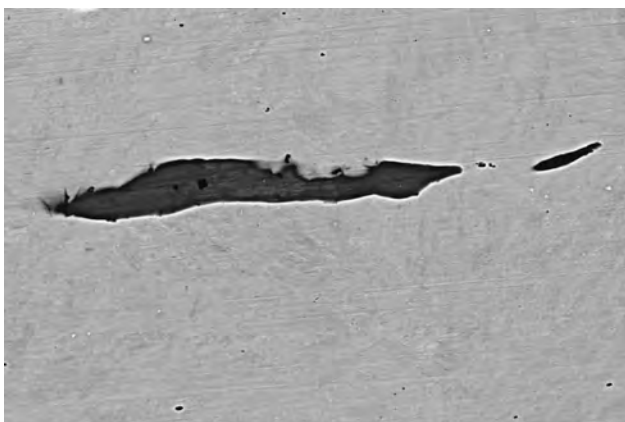
SEM3200 ETD HV MAG HFW WD  
SE 20kV x5000 81.28um 7mm 10um

Alloy fracture brittleness + toughness  
Acceleration voltage: 20 KV/ Magnification: ×5000



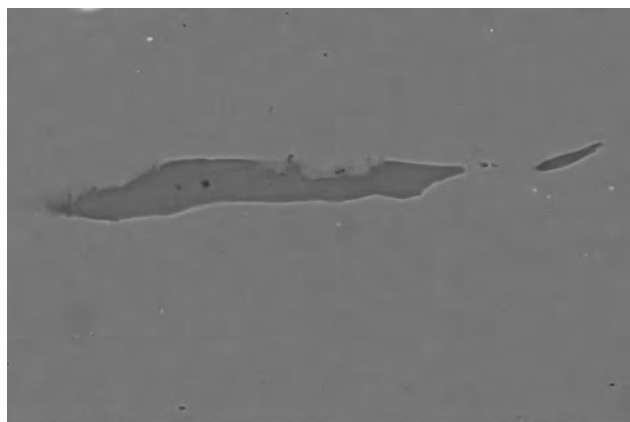
SEM3200 ETD HV MAG.P HFW WD High.V  
SE 20kV x1000 0.13mm 12.96mm 1.9e-3Pa 10um

Ductile fracture  
Acceleration voltage: 20 KV/ Magnification: ×1000



SEM3200 BSED HV MAG.S HFW WD High.V Frames  
Comp 15kV x7000 58.06um 5.15mm 1.4E-3Pa 1 5um

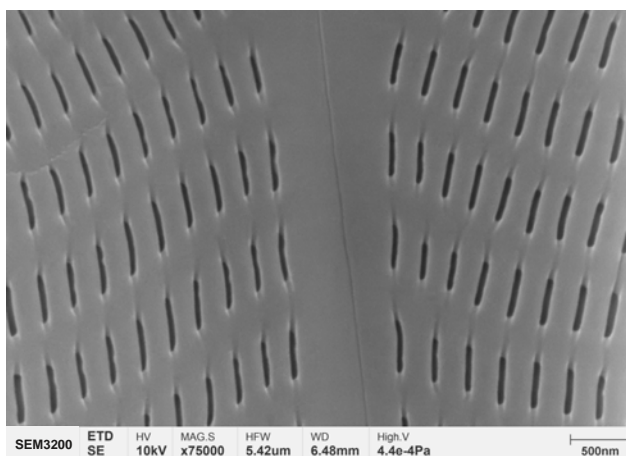
Steel inclusion BSE  
Acceleration voltage: 15 KV/ Magnification: ×7000



SEM3200 ETD HV MAG.S HFW WD High.V Frames  
SE 15kV x7000 58.06um 5.15mm 1.4E-3Pa 1 5um

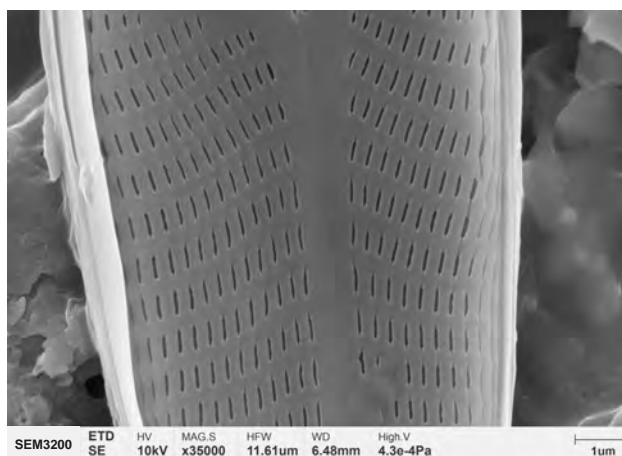
SESteel inclusion SE  
Acceleration voltage: 15 KV/ Magnification: ×7000

## Organism



Diatom-1

Acceleration voltage: 10 KV/ Magnification:  $\times 75000$



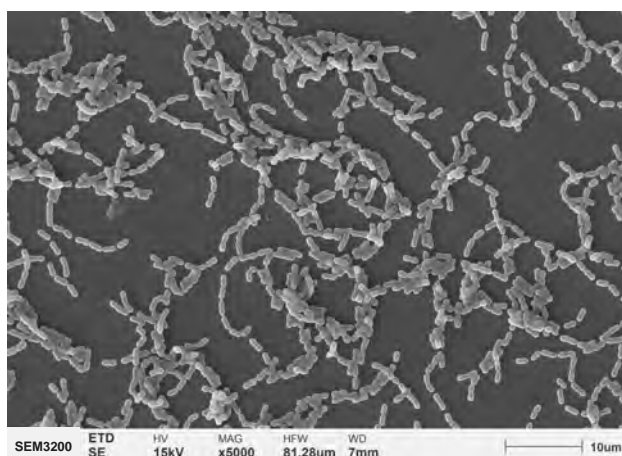
Diatom-2

Acceleration voltage: 10 KV/ Magnification:  $\times 35000$



Staphylococcus galli-1

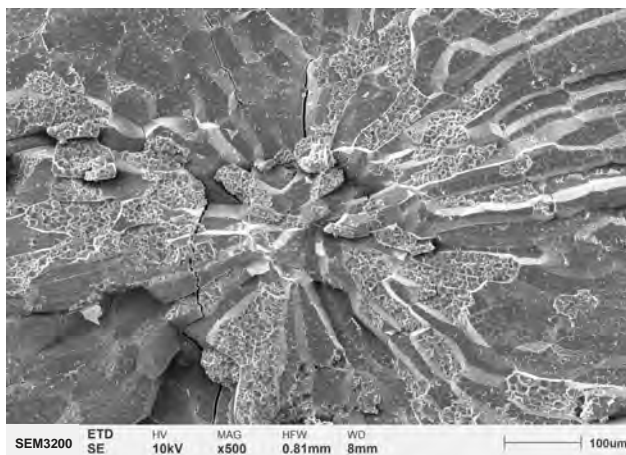
Acceleration voltage: 15 KV/ Magnification:  $\times 20000$



Staphylococcus galli-2

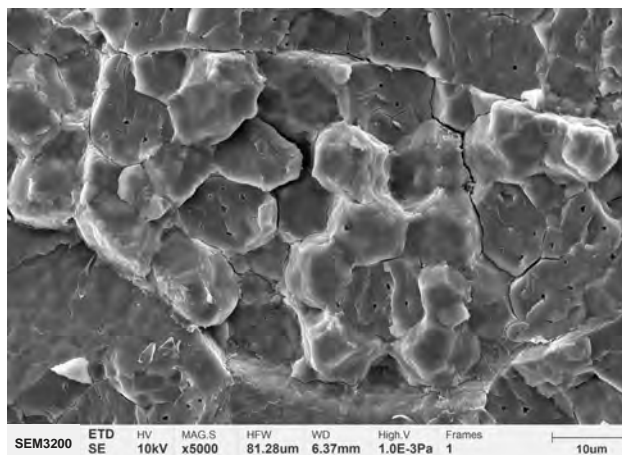
Acceleration voltage: 15 KV/ Magnification:  $\times 5000$

## Food



Rice

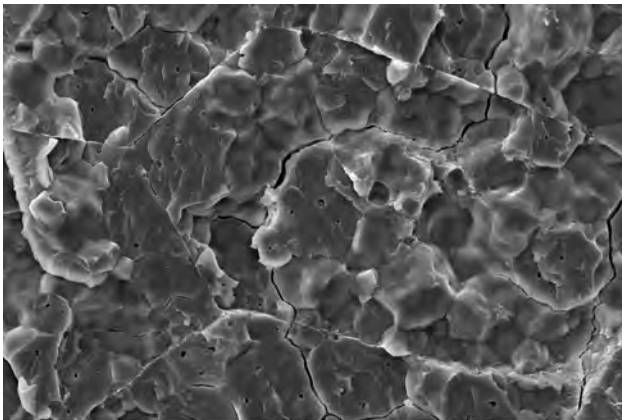
Acceleration voltage: 10 KV/ Magnification:  $\times 500$



Glutinous rice starch granules-1

Acceleration voltage: 10 KV/ Magnification:  $\times 5000$

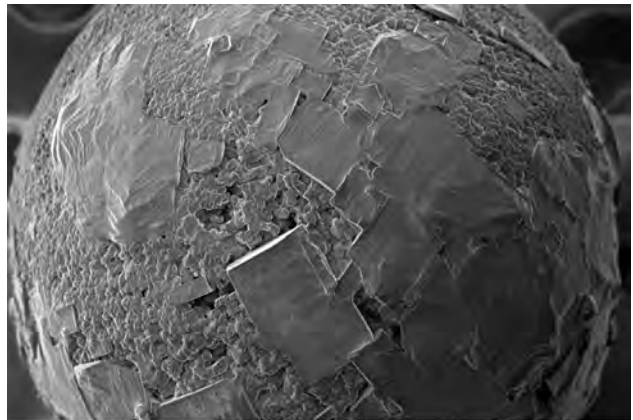




SEM3200 ETD SE HV 10kV MAG.S x5000 HFW 81.28um WD 8.71mm High.V 1.4E-3Pa Frames 1 | 10um

Glutinous rice starch granules-2

Acceleration voltage: 10 KV/ Magnification: ×5000

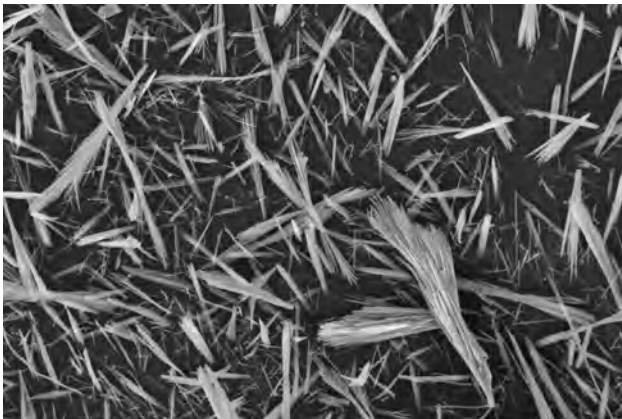


SEM3200 ETD SE HV 1kV MAG.S x500 HFW 0.81mm WD 6.91mm High.V 5.9E-4Pa Frames 1 | 100um

Damp salt particles

Acceleration voltage: 1 KV/ Magnification: ×500

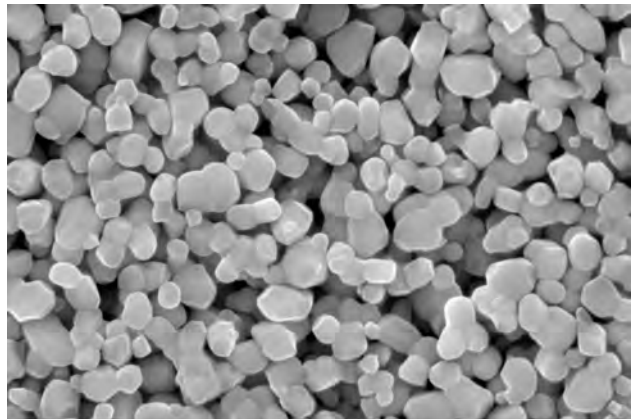
### Basic research



SEM3200 ETD SE HV 15kV MAG x2000 HFW 0.20mm WD 6mm | 20um

Powder - Magnesium sulfate

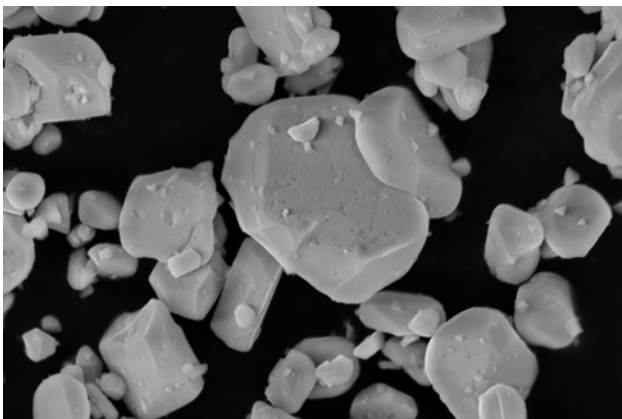
Acceleration voltage: 15 KV/ Magnification: ×2000



SEM3200 ETD SE HV 25kV MAG.S x48000 HFW 8.47um WD 5.93mm High.V 7.3E-4Pa Lines 10 | 1um

Powder - barium titanate

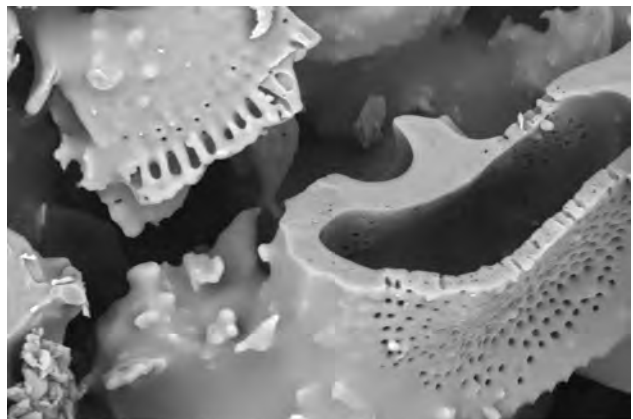
Acceleration voltage: 25 KV/ Magnification: ×48000



SEM3200 ETD SE HV 15kV MAG x10000 HFW 40.64um WD 7mm | 5um

Powder alpha-alumina

Acceleration voltage: 15 KV/ Magnification: ×10000

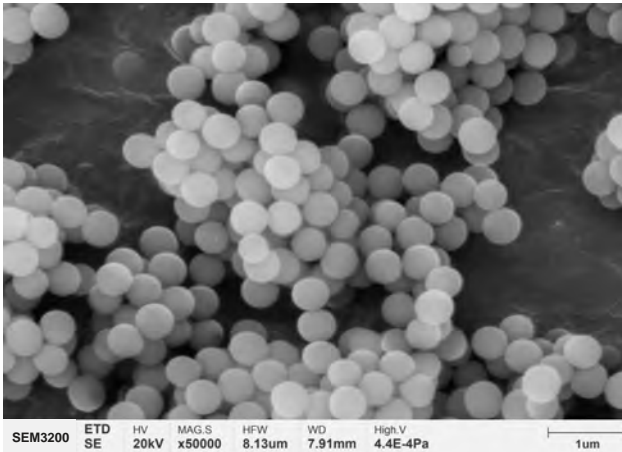


SEM3200 BSED Comp HV 10kV MAG.S x10000 HFW 40.64um WD 7.23mm High.V 6.9e-4Pa | 5um

Filter function material

Acceleration voltage: 10 KV/ Magnification: ×10000

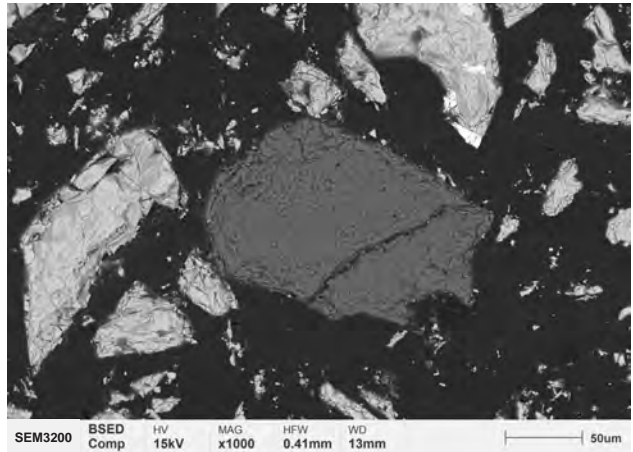
Basic research



Nanomaterial - silica microspheres

Acceleration voltage: 20 KV/ Magnification: ×50000

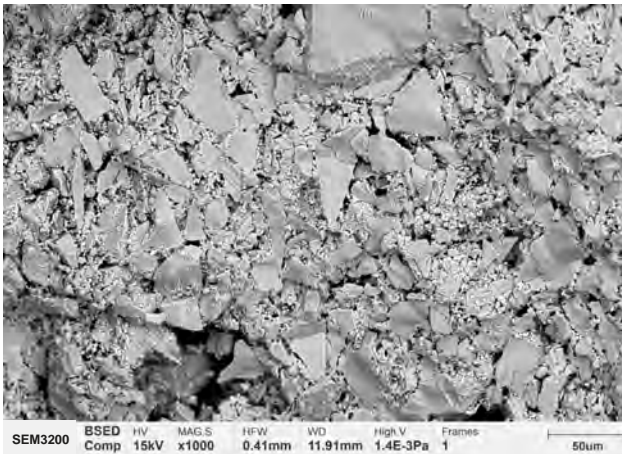
Environment



Rock

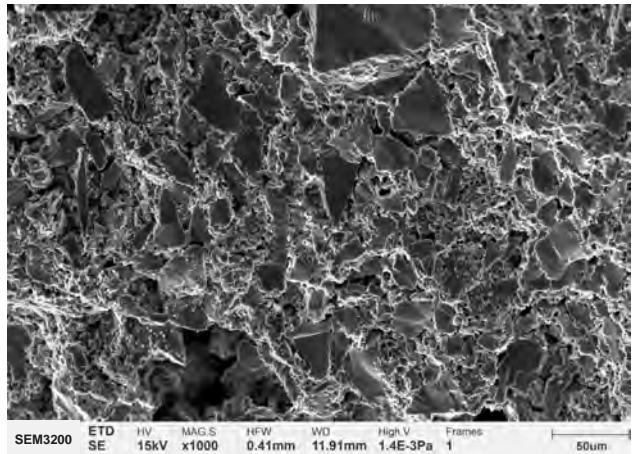
Acceleration voltage: 15 KV/ Magnification: ×1000

Ceramic



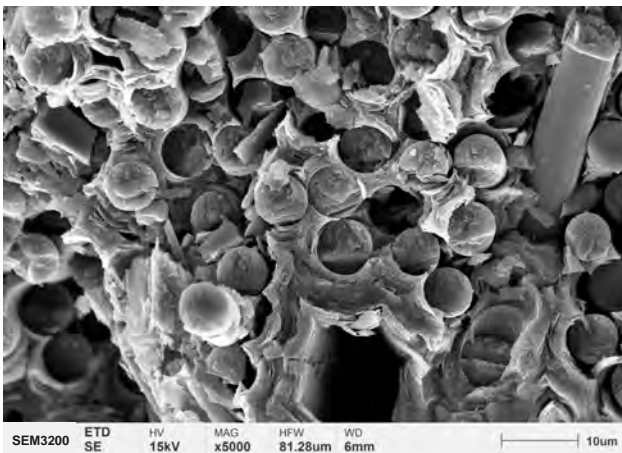
SiC ceramic BSE

Acceleration voltage: 15 KV/ Magnification: ×1000



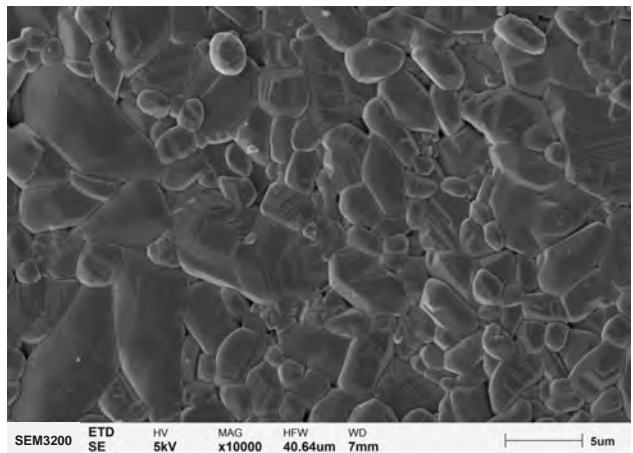
SiC ceramic SE

Acceleration voltage: 15 KV/ Magnification: ×1000



Ceramic composite

Acceleration voltage: 15 KV/ Magnification: ×5000



Ceramic structural material

Acceleration voltage: 5 KV/ Magnification: ×10000



# Products Specifications (\*Optional)

Model		SEM3200A	SEM3200	
Electron optical system	Electron gun	Pre-aligned medium-sized fork-type tungsten filament		
	Resolution	High vacuum	3 nm @ 30 kV (SE) 4 nm @ 30 kV (BSE) 8 nm @ 3 kV (SE)	
		*Low vacuum	3 nm @ 30 kV (SE)	
	Magnification		1~300,000x (film)	
			1~1000,000x (screen)	
Accelerating voltage	0.2 kV~30 kV			
Imaging system	Detector	Secondary electron detector (ETD) *EBSD、*Low vacuum SED、*EDS		
	Image format	TIFF、JPG、BMP、PNG		
Vacuum system	Vacuum mode	High vacuum	Better than $5 \times 10^{-4}$ Pa	
		*Low vacuum	5~1000 Pa	
	Control mode	Full automatic		
	Turbo molecular pump	$\geq 240$ L/S		
	Mechanical pump	200 L/min (50 Hz)		
Sample room	Camera	Optical navigation		
		Monitoring		
	Sample stage	Three axis automatic	Five axis automatic	
	Distance	X: 120 mm	X: 120 mm	
		Y: 115 mm	Y: 115 mm	
		Z: 50 mm	Z: 50 mm	
		/	R: 360°	
/	T: -10°~ +90°			
Software	Language	Chinese/English		
	OS	Windows		
	Navigation	Optical navigation, gesture quick navigation		
	Automatic function	Auto brightness contrast, auto focus, auto astigmatism		
	Featured function	Intelligent assisted astigmatism, maximum image Mosaic (optional software)		
Installation Requirements	Size	L $\geq 3000$ mm, W $\geq 4000$ mm, H $\geq 2300$ mm		
	Temperature	20 °C~25 °C		
	Humidity	$\leq 50$ %		
	Electrical power	AC 220 V( $\pm 10$ %), 50 Hz, 2 kVA		



Hefei, China



Wuxi, China